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Slow Shallow Energy States as the Origin of Hysteresis in Perovskite Solar Cells

Rik van Heerden¹, Paul Procel^{1,2*}, Luana Mazzarella¹, Rudi Santbergen¹ and Olindo Isabella¹

¹PVMD Group, Delft University of Technology, Delft, Netherlands, ²Instituto de Micro y Nanoelectrónica - Universidad San Francisco de Quito, Quito, Ecuador

Organic-inorganic metal halide perovskites have attracted a considerable interest in the photovoltaic scientific community demonstrating a rapid and unprecedented increase in conversion efficiency in the last decade. Besides the stunning progress in performance, the understanding of the physical mechanisms and limitations that govern perovskite solar cells are far to be completely unravelled. In this work, we study the origin of their hysteretic behaviour from the standpoint of fundamental semiconductor physics by means of technology computer aided design electrical simulations. Our findings identify that the density of shallow interface defects at the interfaces between perovskite and transport layers plays a key role in hysteresis phenomena. Then, by comparing the defect distributions in both spatial and energetic domains for different bias conditions and using fundamental semiconductor equations, we can identify the driving force of hysteresis in terms of slow recombination processes and charge distributions.

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*Correspondence:

Paul Procel
p.a.procelmoya@tudelft.nl

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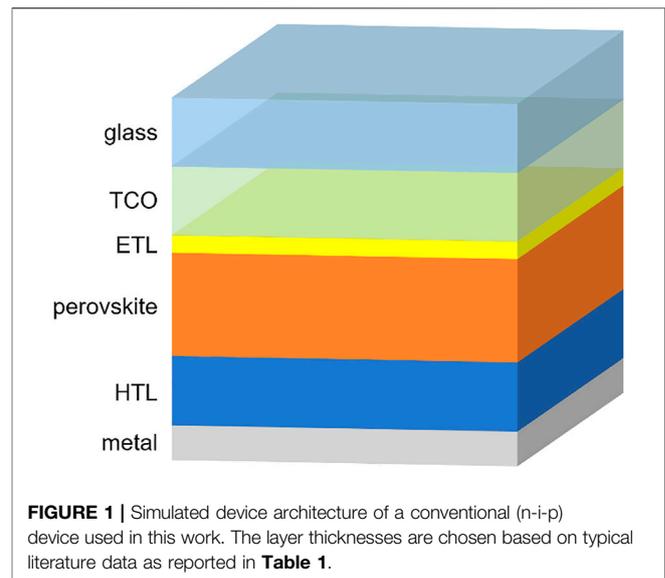
INTRODUCTION

Organic-inorganic metal halide perovskites are a promising class of absorber materials for photovoltaic applications because of their outstanding opto-electronic properties such as high absorption coefficient, long carrier diffusion length and low non-radiative carrier recombination (Green et al., 2014; Tonui et al., 2018). Furthermore, they are characterized by easy fabrication at potential low cost fabrication processes. Moreover, the bandgap can be tuned from the near-infrared to the visible region of the electromagnetic spectrum by compositional engineering (Tao et al., 2019), making perovskites suitable candidates for various opto-electrical applications beyond single junction solar cells, for example multi-junction solar cells (Lal et al., 2017; Li and Zhang, 2020), photodetectors (Miao and Zhang, 2019; Li et al., 2020) and light emitting diodes (Tan et al., 2014; Ji et al., 2021).

In particular, research and development of perovskite solar cells (PSCs) have rapidly evolved during the last years (Yan et al., 2022). The first perovskite cell reported in 2009 was unstable and exhibited limited conversion efficiency of only 3.8% (Kojima et al., 2009), yet the current world record cell has an efficiency exceeding 25% (Li, 2019; Green et al., 2020). The material properties of perovskites offer advantages to either simplify or diversify the manufacture of high-performance devices such as flexible, semi-transparent, or tandem cell structures. In particular, the integration of perovskite in tandem cells with silicon or CIGS appears very promising (Green et al., 2014; Almansouri et al., 2015; Hörantner et al., 2017; Yu et al., 2016; Al-Ashouri et al., 2020; Lin, 2019) as well as all-perovskite double- and triple-junction devices (Xiao, 2020a; Xiao, 2020b).

Moreover, perovskite PV technology is now approaching the industrialization stage with predicted commercialization over the coming years (Nature Energy, 2020; VDMA, International, 2021; Yan et al., 2022). Nevertheless, material improvements in terms of high efficiency and stability are crucial topics to be addressed for the future of perovskite PV technology.

PSCs are notorious for their hysteresis in the current-voltage curves (J - V) under illumination that strongly depends on the history of the device such as preconditions, light soaking, and on the scan direction as well as scan rate (Elumalai and Uddin, 2016). Hysteresis, also observed under dark conditions (Almora et al., 2015), complicates the device characterization leading to under- or overestimation of the power conversion efficiency, depending on the scan direction. Anomalous hysteresis behaviours have been observed and reported by many research groups (Sanchez et al., 2014; Snaith et al., 2014; Unger et al., 2014; Tress et al., 2015; Wu et al., 2016; Rong et al., 2017; Nemnes et al., 2018), nevertheless the underlying physical mechanisms are not yet completely understood. Hysteresis has been suggested to originate from trapping and de-trapping of charge carriers, (slow) ion-migration, ferroelectric behaviour of the perovskite or polarization processes in crystallographic phases of the material (Unger et al., 2014; Almora et al., 2015; Tress et al., 2015). Understanding the nature behind hysteresis is imperative to provide useful insights for further progress and performance improvements. So far, there is no theoretical study published to unveil the origin of hysteresis which is entirely founded on fundamental semiconductor physics. This is because of the inherent complexity and numerical stability of related computer simulations when attempting to emulate the unique opto-electrical properties of perovskite materials and devices. Van Reenen et al. (van Reenen et al., 2015) already revealed that trap-assisted recombination at the interface between transport layers and perovskite bulk plays a key role in the emergence of current-voltage hysteresis. However, hysteresis in their model was an inherent result of ion migration through the perovskite material. Because of the lack of experimental data of perovskite properties such as defect densities, capture coefficients, and doping, a near universal assumption of mobile ions was assumed in other simulation studies to describe the remarkable transient behaviour (Calado et al., 2016; Neukom, 2019). In such models, a fraction of the ions is mobile and able to move freely through the perovskite layer. These simulations account the mobile ions as a specialized semi-empirical model coupled in semiconductor equations to describe hysteretic behaviour in perovskite solar cells. However, semiconductor physics points out that recombination due to defects with particular characteristics affects the properties of the materials (Das et al., 2020) that in turn influence the transient response of perovskite solar cells. This work therefore presents a novel theoretical study of the hysteresis phenomena in PSCs from the standpoint of fundamental theory of defects in semiconductors. Finding of our modelling reveal the characteristics of energy states, in both space and energy domains, that could produce hysteretic behaviour in PSCs.



SIMULATION METHODOLOGY

For our computational study, we chose a device based on a typical n-i-p architecture. A generic sketch of the solar cells is depicted in **Figure 1**. The absorber layer consists of the archetypal methylammonium lead iodide (MAPbI_3) perovskite. The electron transport layer (ETL) and hole transport layer (HTL) parameters are chosen to resemble the opto-electrical behaviour of TiO_2 and spiro-OMeTAD, respectively. The parameters for modelling the transparent conductive oxide (TCO) layer are chosen to mimic indium tin oxide (ITO). The simulation parameters used in this work can be found in **Table 1**. Based on a finite element method-based technology computer aided design (TCAD Sentaurus) (Synopsys, 2015), the drift-diffusion model is numerically solved including consistent trap-assisted recombination, Auger recombination and radiative recombination. The transfer-matrix method is used to compute the optical generation inside the device. Carrier transport at material interfaces is modelled with thermionic emission and tunnelling. By default, we use the model based on Fermi-Dirac statistics and quasi-Fermi levels to emulate the occupation of energy states. We model band tail states based on theory by J. F. Wager (Wager, 2017). The corresponding parameters for recombination are summarized in **Table 2**. Transient simulations are used to emulate the reverse scan (i.e. decreasing applied bias from open-circuit condition) and the forward scan (i.e., increasing applied bias from short-circuit current density condition). These simulations are then compared to steady-state simulations, in which there is no temporal change. Finally we show that our model can be extended to inverted PSCs as p-i-n structure. The corresponding modelling parameters of such p-i-n PSCs are based on Ref. (Neukom, 2019) and summarized in **Table 3**. A simple band-to-band tunnelling model is used for the inter-band charge transfer between the TCO and HTL (Procel et al., 2020).

TABLE 1 | Material and device parameters of the layers forming the generic PSC (n-i-p) as reported in **Figure 1**. ϵ_r is the relative permittivity, E_G is the bandgap energy, X is the electron affinity, N_C is the effective density of states of the conduction band, N_V is the effective density of states of the valence band, N_D the concentration of ionized donors, N_A is the concentration of ionized acceptors, μ_n is the electron mobility and μ_p is the hole mobility.

	ITO	TiO ₂	CH ₃ NH ₃ PbI ₃	Spiro-OMeTAD
Thickness (nm)	300	50	400	200
ϵ_r	3.5	60 Campbell et al. (1999)	30 Poglitsch and Weber, (1987)	3 Poplavskyy and Nelson, (2003)
E_G (eV)	3.1	3.2 Liu et al. (2014)	1.5 Chueh et al. (2015)	3.0 Liu and Kelly, (2014)
X (eV)	4.7	4 Liu et al. (2014)	3.9 Chueh et al. (2015)	2.2 Wang et al. (2009)
N_C (cm ⁻³)	4.1×10^{18}	1×10^{21} Liu et al. (2014)	2×10^{18} Minemoto and Murata, (2014)	1×10^{18} Liu et al. (2014)
N_V (cm ⁻³)	1.7×10^{19}	2×10^{20} Liu et al. (2014)	2×10^{19} Minemoto and Murata, (2014)	1×10^{20} Liu et al. (2014)
N_D (cm ⁻³)	1×10^{20}	5×10^{17} Sellers and Seebauer, (2011)	0	0
N_A (cm ⁻³)	0	0	0	3×10^{18} García-Cañadas et al. (2006)
μ_n (cm ² V ⁻¹ s ⁻¹)	160	6×10^{-3} Liu et al. (2014)	0.7 Stranks et al. (2013)	1×10^{-4} Snaith and Grätzel, (2006)
μ_p (cm ² V ⁻¹ s ⁻¹)	40	6×10^{-3} Liu et al. (2014)	0.4 Stranks et al. (2013)	1×10^{-4} Snaith and Grätzel, (2006)

TABLE 2 | Parameters used for carrier recombination models.

Parameter	Value	Unit	Description
β	1×10^{-10}	cm ³ s ⁻¹	Radiative recombination
C_n	1×10^{-28}	cm ⁶ s ⁻¹	Auger recombination (eeh)
C_p	1×10^{-28}	cm ⁶ s ⁻¹	Auger recombination (ehh)

TABLE 3 | Material and device parameters of the inverted PSC (p-i-n) with N4''-tetra[[1,1'-biphenyl]-4-yl]-[1,1':4',1''-terphenyl]-4,4''-diamine (TaTm) as HTL and C₆₀ as ETL [based on (Neukom, 2019)]

	ITO	TaTm	CH ₃ NH ₃ PbI ₃	C ₆₀
Thickness (nm)	200	50	500	50
ϵ_r	3.5	3	30	3.9
E_G (eV)	3.1	1.79	1.62	1.92
X (eV)	4.7	3.59	3.82	3.85
N_C (cm ⁻³)	4.12×10^{18}	1×10^{21}	2×10^{18}	1×10^{21}
N_V (cm ⁻³)	1.7×10^{19}	1×10^{21}	2×10^{19}	1×10^{21}
N_D (cm ⁻³)	1×10^{20}	0	0	1.5×10^{18}
N_A (cm ⁻³)	0	7×10^{18}	0	0
μ_n (cm ² V ⁻¹ s ⁻¹)	160	1.5×10^{-3}	0.7	8.9×10^{-4}
μ_p (cm ² V ⁻¹ s ⁻¹)	40	1.5×10^{-3}	0.4	8.9×10^{-4}

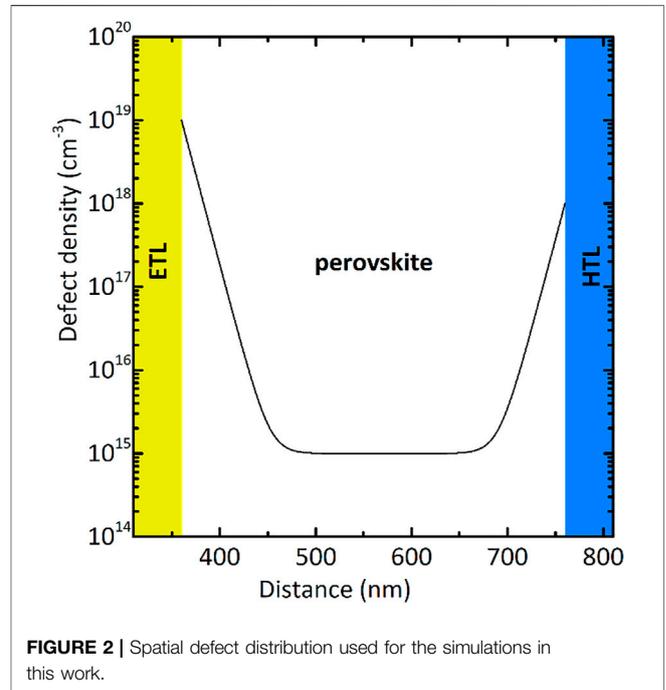


FIGURE 2 | Spatial defect distribution used for the simulations in this work.

Modelling of Defects and Energy States

Ni et al. (2020) showed a clear decrease in defect density with the distance from the interface. Based on that insight, we use a novel approach to model the spatial distribution of defects. **Figure 2** shows the spatial profile that we use in our simulations represented by an exponential function. Accordingly, defect densities are much higher at the perovskite interfaces adjacent to the transport layers and strongly decrease inside the absorber bulk, thus emulating the observations reported in (Ni et al., 2020). Penetration depths δ_{ETL} and δ_{HTL} parametrize how far interface defects extend into the bulk. The defect density is given by:

$$N_t = N_{t,ETL} \exp\left(\frac{x_{ETL} - x}{\delta_{ETL}}\right) + N_{t,bulk} + N_{t,HTL} \exp\left(\frac{x - x_{HTL}}{\delta_{HTL}}\right) \quad (1)$$

where $N_{t,ETL}$ and $N_{t,HTL}$ are the defect densities at the ETL/perovskite and HTL/perovskite interfaces, x_{ETL} and x_{HTL} are the

positions of the respective interfaces and $N_{t,bulk}$ is the bulk defect density. In conformity with the measurements from Ni et al. (2020), we assume that $N_{t,HTL}$ and $N_{t,ETL}$ are equal to 10^{18} cm⁻³ and 10^{-15} cm⁻³, respectively.

The energetic defect density profile is modelled using a Gaussian distribution.

$$N_t = N_{t,0} \exp\left(-\frac{(E - E_{t,0})^2}{2E_S^2}\right) \quad (2)$$

Here $N_{t,0}$ is the maximum defect density, $E_{t,0}$ the average defect energy and E_S the standard deviation of the Gaussian distribution. Evidence has been found for the existence of defects with transition energies around 0.15–0.30 eV (Duan et al., 2015; Heo et al., 2015). This simplified model is in agreement with a typical defect energy distribution as measured by Duan et al. (2015). In our simulations we used the parameters summarized in **Table 4**.

TABLE 4 | Default parameters used within our analysis of the slow defects.

Parameter	Value	Unit	Description
$E_{t,0}$	0.25 (varied)	eV	Average defect energy of Gaussian distribution
E_S	0	meV	Standard deviation of Gaussian distribution
$N_{t,ETL}$	1×10^{18} (varied)	$\text{cm}^{-3} \text{eV}^{-1}$	Defect density at ETL/perovskite interface
$N_{t,HTL}$	1×10^{18} (varied)	$\text{cm}^{-3} \text{eV}^{-1}$	Defect density at HTL/perovskite interface
$N_{t,bulk}$	1×10^{15}	$\text{cm}^{-3} \text{eV}^{-1}$	Bulk defect density
δ_{ETL}	100	nm	ETL interface defect depth
δ_{HTL}	100	nm	HTL interface defect depth
σ_n	1×10^{-23} (varied)	$\text{cm}^2 \text{s}^{-1}$	Electron capture cross-section
σ_p	1×10^{-23} (varied)	$\text{cm}^2 \text{s}^{-1}$	Hole capture cross-section

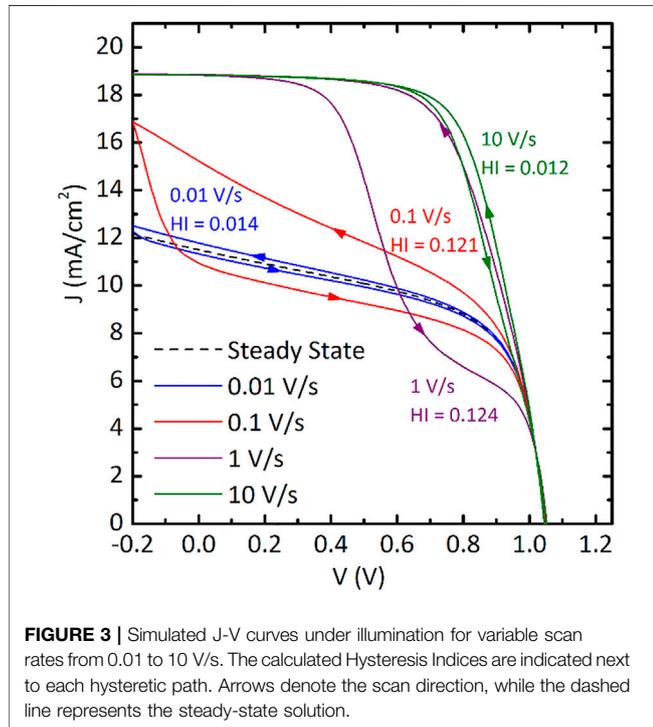


FIGURE 3 | Simulated J-V curves under illumination for variable scan rates from 0.01 to 10 V/s. The calculated Hysteresis Indices are indicated next to each hysteretic path. Arrows denote the scan direction, while the dashed line represents the steady-state solution.

We consider double-state defects in the spatial and energy domain. In this work we focus on acceptor-like defects near the ETL and donor-like defects near the HTL, because we found that these energy states are active during the recombination processes in PSC simulations. It is worth mentioning that, in semiconductor materials, defects are commonly related to grain size and interface imperfections (Sze and Ng, 2006) and, in particular for PSC materials, defects can be ascribed to ions (Srivastava et al., 2020).

To quantify the magnitude of the hysteretic behaviour, we adopt the Hysteresis Index (HI) as defined by Nemnes et al. (2018), where the subscripts FS and RS indicate *forward scan* and *reverse scan*, respectively:

$$HI = \frac{\int_0^{V_{OC,RS}} J_{RS}(V) dV - \int_0^{V_{OC,FS}} J_{FS}(V) dV}{\int_0^{V_{OC,RS}} J_{RS}(V) dV + \int_0^{V_{OC,FS}} J_{FS}(V) dV}$$

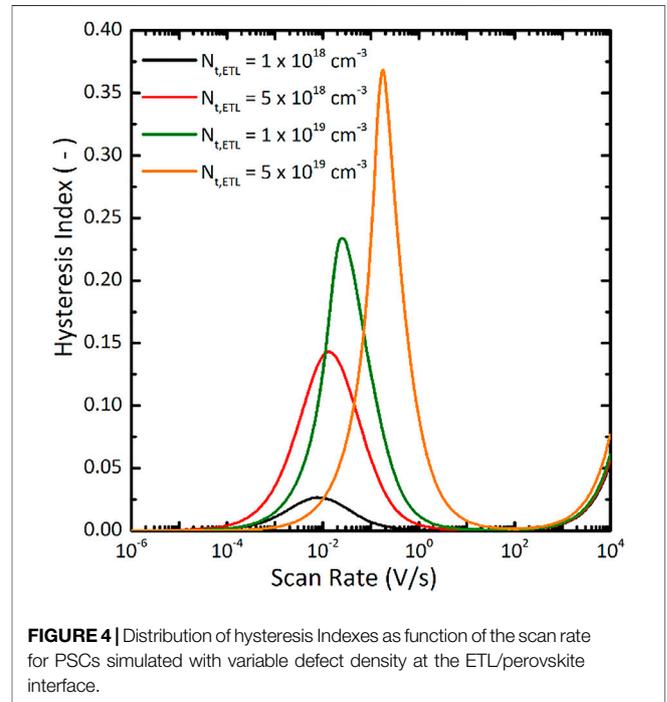


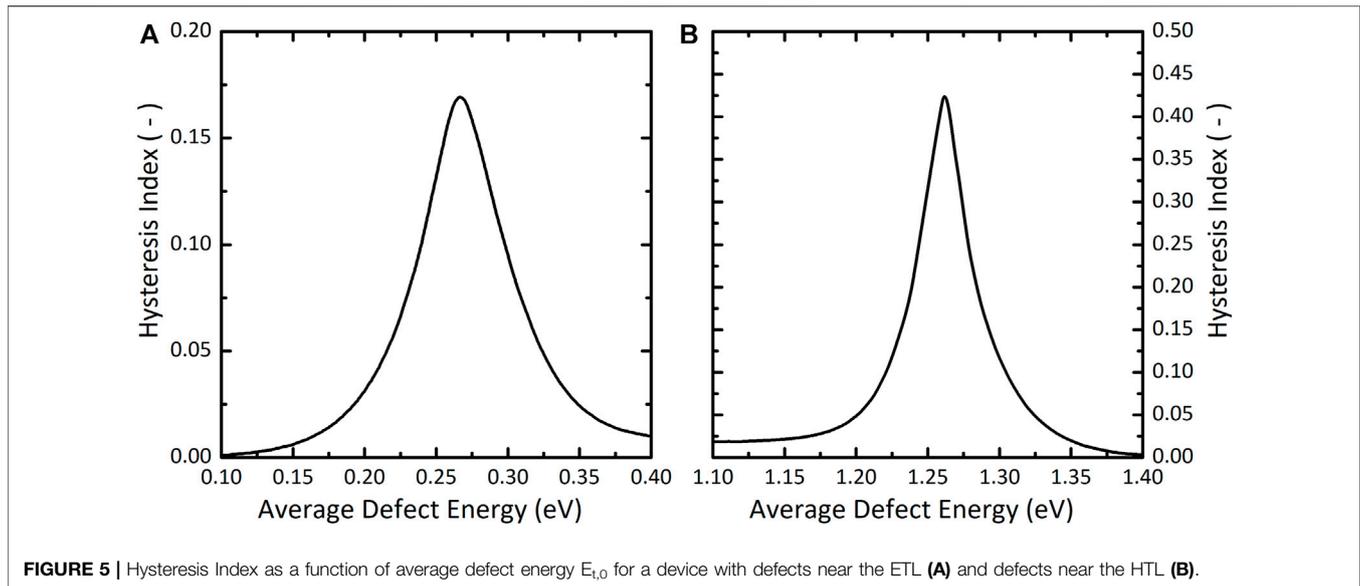
FIGURE 4 | Distribution of hysteresis indexes as function of the scan rate for PSCs simulated with variable defect density at the ETL/perovskite interface.

The Hysteresis Index is normalized, so that $-1 < HI < 1$. Larger (absolute) values of HI correspond to stronger hysteresis, with positive values corresponding to normal hysteresis and negative values corresponding to inverted hysteresis. In general, normal and inverted hysteresis indicate that J-V curves from reverse scan or forward scan cover higher J values in the voltage domain than in case of forward scan or reverse scan, respectively. For reference, HI = 0 indicates a PSC which is hysteresis-free.

SIMULATION RESULTS

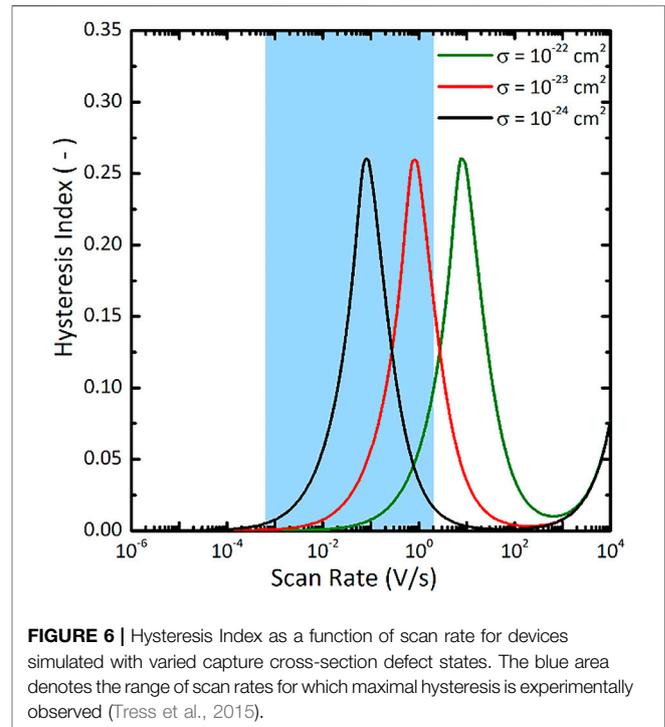
Hysteresis and Energy States

We first perform transient (time domain) simulations to evaluate the effect of the scan rate in a n-i-p device considering forward and reverse scan. **Figure 3** shows simulated J-V curves of our reference n-i-p PSC under illumination for a range of scan rates between 0.01 and 1 V/s with their respective HI. We observe

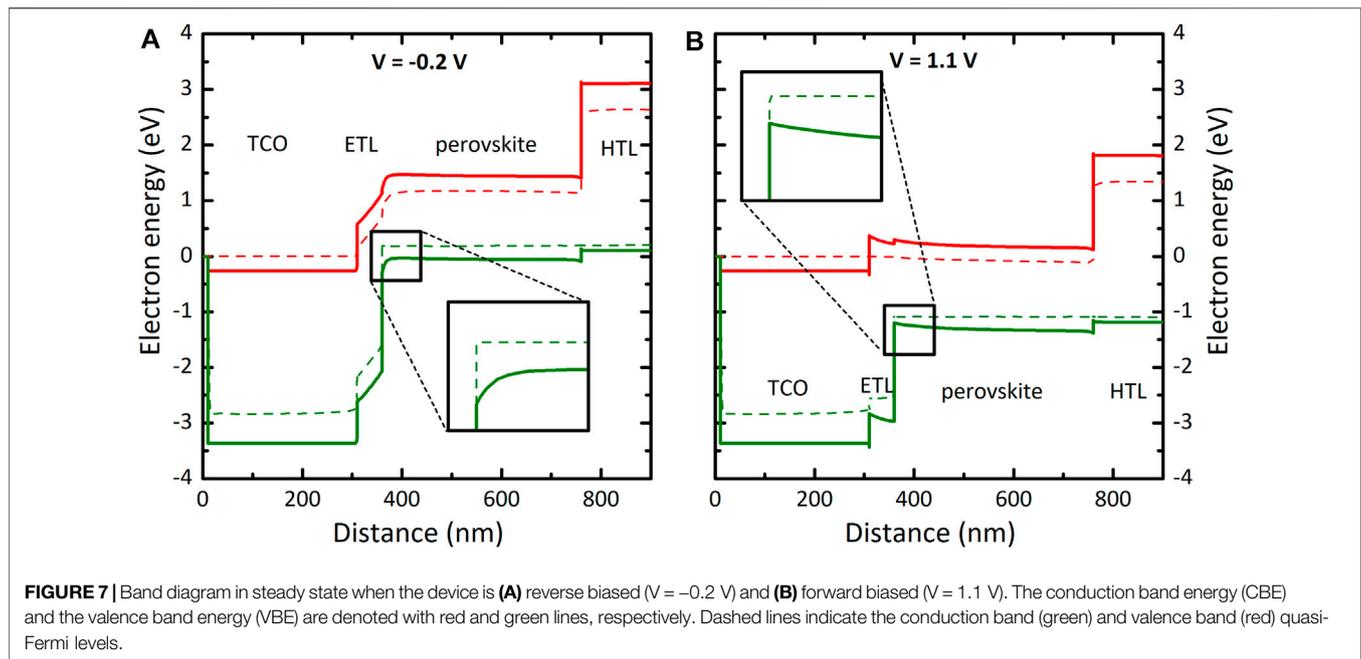


pronounced hysteresis ($HI > 0.1$) at scan rates in the range from 0.1 to 1 V/s. For slower scan rates hysteresis decreases, as both FS and RS approach the steady state J - V curve. In steady state the device is assumed to be in equilibrium, showing the long-term response of the system. The fact that in our simulations the steady-state J - V curve (dashed line in **Figure 3**) lies much lower than the J - V curves at high scan rates, reflects that the performance of the device degrades over a relatively short time (tens to hundreds of seconds). We observe a relatively low short circuit current due to the high interfacial defect densities that result in high recombination rates. On the contrary, for higher scan rates we observe reduced hysteresis, which goes along with improved performance. This reveals the complex process for device characterisation. In fact, the stable power conversion efficiency (as determined by the steady-state response) for this device cannot be accurately determined using scan rates higher than 0.01 V/s. The observed scan-rate dependency is in line with trends reported in literature (Snaith et al., 2014; Tress et al., 2015).

To analyse how interface defects near the ETL/perovskite interface influence hysteresis, cells with different values of peak of ETL defect density ($N_{t, ETL}$) were simulated. In **Figure 4** the calculated Hysteresis Index is plotted as a function of scan rate for different $N_{t, ETL}$ values. All the other parameters were kept constant as reported in **Table 3**. As expected, for low $N_{t, ETL}$ ($1 \times 10^{18} \text{ cm}^{-3}$) the HI exhibits the lowest values which stay below 0.03. By increasing the $N_{t, ETL}$ up to $5 \times 10^{19} \text{ cm}^{-3}$, the HI rapidly increases above 0.35. Due to the capacitive nature of photovoltaic devices, the HI is almost insensitive to the defect density for scan rates above 100 V/s. Indeed, HI variation is similar among $N_{t, ETL}$ values scan rate >100 V/s. Note that HI increases for scan rate >100 V/s because of transition times between measurements are smaller than the time to fully arrange the charge inside the device to the voltage in stable conditions. This results in a measurement that depends on the previous condition of the device and increases HI.



We found that the hysteresis directly correlates with the defect density at transport layer/perovskite interface. At this point, to study the effect of the energy of those defect states on the hysteresis, we simulated PSC's featuring $E_{t,0}$ ranging between 0.1 to 0.4 eV and 1.1–1.4 eV for defects close to ETL and HTL, respectively. **Figure 5** shows the Hysteresis Index as a function of average defect energy for defects near the ETL (a) and defects near the HTL (b). For defects near the ETL, hysteresis is most apparent for $E_{t,0} = 0.27$ eV while for defects near the HTL the maximum occurs at $E_{t,0} = 1.26$ eV. In general our simulations show that



defects with energy close to the valence band quasi Fermi level ($E_{F,p}$) or conduction band quasi Fermi level ($E_{F,n}$) near the ETL and HTL, respectively, cause most severe hysteresis.

Besides studying the effect of N_t at the interface (see **Figure 4** $E_{T,0}$ (see **Figure 5**) on the HI, we also analyse the effect of the capture cross-section (σ) of the defect states in the perovskite absorber bulk on the hysteresis. **Figure 6** shows the HI as a function of scan rate for 3 cells with different capture cross-sections. The scan rate at which the HI is maximal decreases for lower capture cross-sections. In practice, hysteresis is observed for the commonly used range of 10^{-3} V s $^{-1}$ – 10^0 V s $^{-1}$ (Snaith et al., 2014; Tress et al., 2015). Our results show that σ thus should be lower than 10^{-23} cm 2 to reproduce this behaviour. This value is extremely low compared to defects associated to other well-known semiconductor materials such as Si (Sze and Ng, 2006; Procel et al., 2020), SiO $_2$ (Eades and Swanson, 1985) and GaAs (Lang and Logan, 1975).

Moreover, the calculated σ based on the formula in ref. (Heiman and Warfield, 1965) and the experimental frequency response for ionic transport ($\tau^{-1} < 10^2$ Hz) (Srivastava et al., 2020) is consistent with our findings reported in **Figure 6** ($\sigma < 10^{-22}$ cm 2). This suggests that low σ can be correlated to ionic transport as discussed in ref. (Srivastava et al., 2020).

In fact, the frequency response of defect states (or alternately the capture and emission times) is proportional to the capture cross section (Sze and Ng, 2006). Therefore, we can relate the low capture cross sections with slow capture-emission processes.

Slow Dynamic Processes

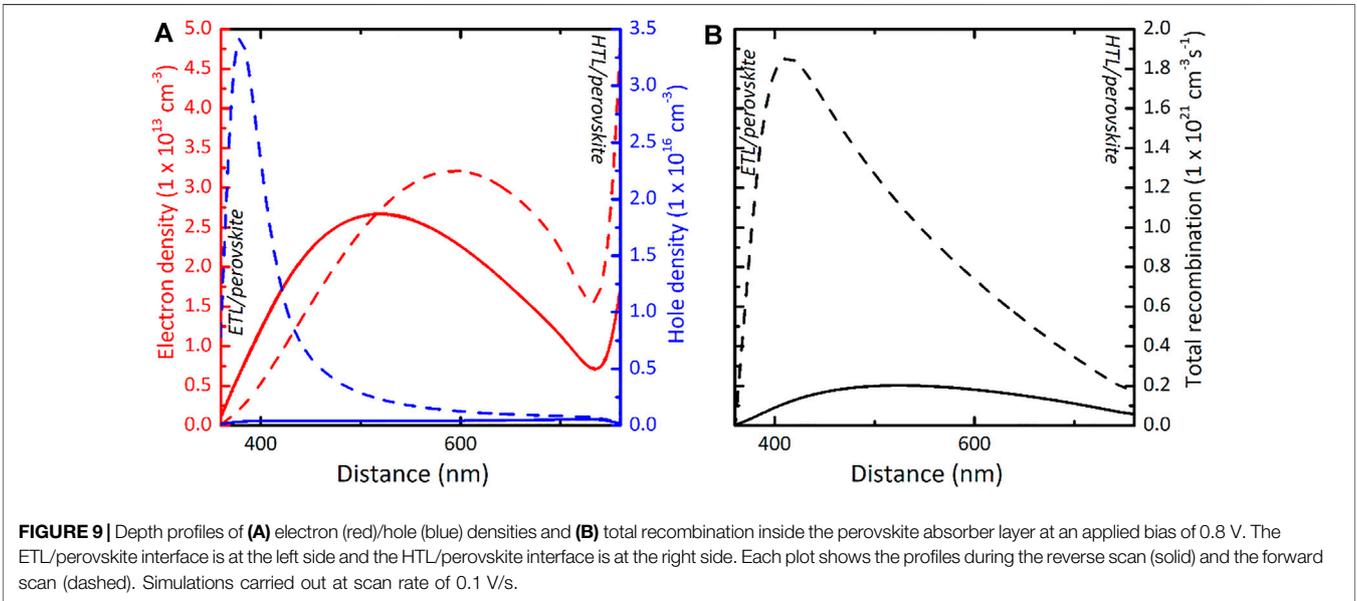
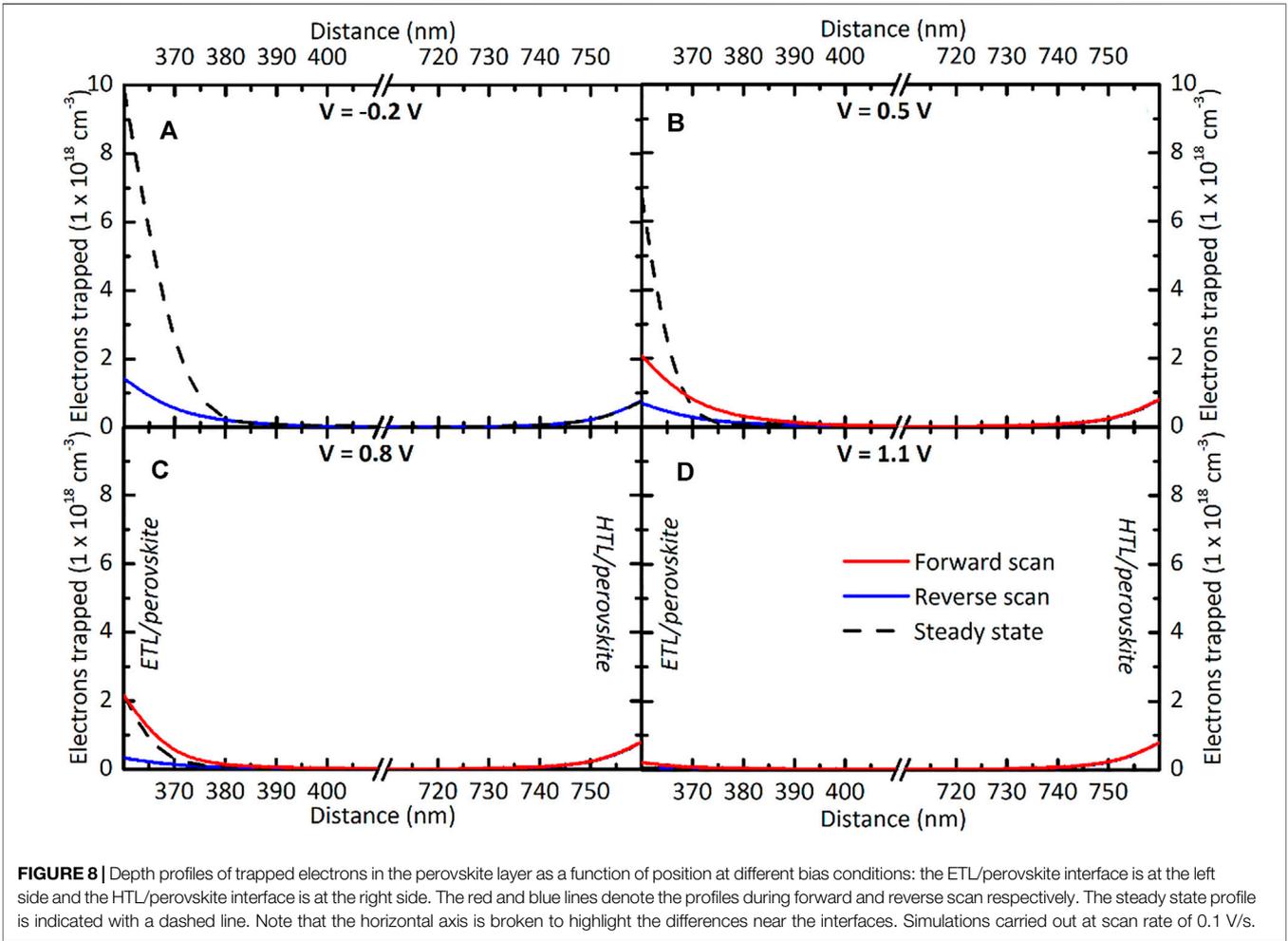
Hysteresis in our simulated devices is attributable to slow capture and release of charge carriers by defects. The high amount of defect states near the interface gives rise to charge accumulation near the interface(s) and we can visualize that in **Figure 7** for different voltage bias.

Figures 7A, B show the band diagram in steady state when the device is reverse biased (-0.2 V) and forward biased (1.1 V), respectively. We observe that near the ETL/perovskite interface $E_{F,p}$ is closer to the valence band energy (VBE) in forward bias than it is in reverse bias. Consequently, approaching the ETL interface, the concentration of holes (electrons) tends to be lower (higher) in reverse (forward) bias.

Indeed, in **Figure 8**, we observe the variation of concentration of electrons for different bias conditions: reverse bias ($V = -0.2$ V), forward bias ($V = 1.1$ V) and for two additional bias at $V = 0.5$ V and $V = 0.8$ V. There, we distinguish the steady state (dashed), forward scan (red) and reverse scan (blue) curves. Note that the scan starts at $V = 1.1$ V (blue curve in **Figure 8D**), switches scan direction at $V = -0.2$ V (blue and red curve in **Figure 8A**) and ends at $V = 1.1$ V (red curve in **Figure 8D**). The tendency of carrier trapping can be derived by taking the steady state profile as reference. That is, the transient profiles follow the steady-state profile: if the profile is below the steady state profile, the amount of trapped electrons tend to increase and if it is above the steady state profile, it tends to decrease.

Comparing **Figure 8A** and **Figure 8D**, we notice that much more charge is trapped in reverse bias (**Figure 8A**) near the ETL/perovskite interface. The lower concentration of holes (and higher concentration of electrons) causes a higher concentration of trapped electrons in reverse bias. Consequently, electrons must be released during the forward scan and captured during the reverse scan.

Because the processes of capture and emission are relatively slow compared to the scan rate, different profiles appear for the forward scan and reverse scan in **Figure 8B** and **Figure 8C**. During the reverse scan a relatively low amount of electrons is trapped because the capture process is incomplete and we assumed no trapped charge trapped as the initial conditions of our device (**Figure 8D**). On the other hand, during the forward



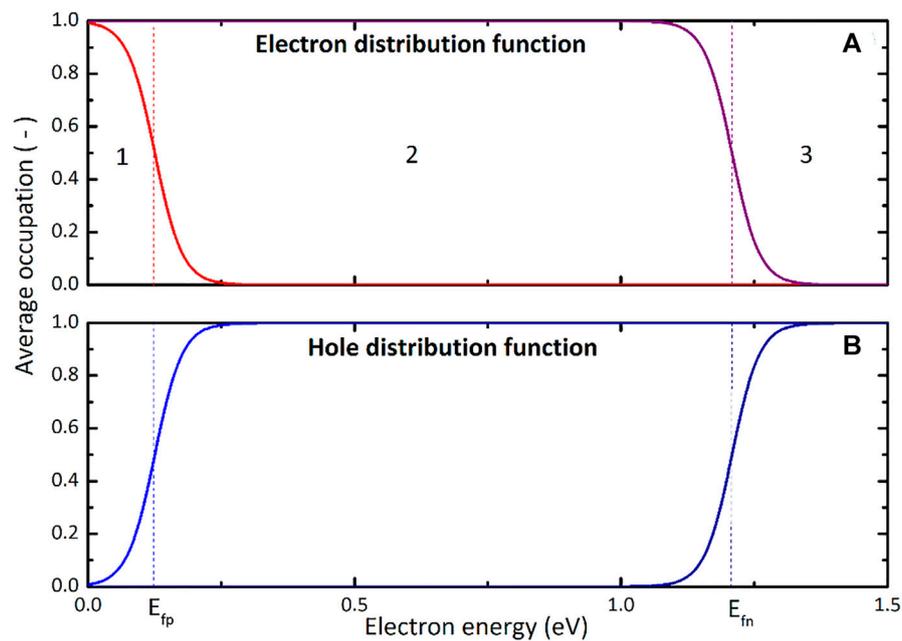


FIGURE 10 | (A) Fermi-Dirac distribution function corresponding to the valence band (light red) and conduction band (dark red). **(B)** Distribution functions for holes, i.e. the complementary probability distributions of the Fermi-Dirac distributions in the top graph. The light blue curve corresponds to the valence band and the dark blue curve to the conduction band. Dashed lines indicate the quasi-Fermi levels. Recombination at ETL and HTL interfaces.

scan the amount of electrons trapped is relatively high, as the process to release all the carriers that were trapped in reverse bias is incomplete (**Figure 8A**).

The higher concentration of trapped charge near the interface results in an electric field inside the absorber layer bulk that points in the direction of the ETL during the forward scan. Thus, during the forward scan, the trapped electrons effectively screen the internal electric field. To visualize that, we plot in **Figure 9A** the electron/hole densities profile inside the perovskite absorber layer for a constant voltage value of 0.8 V. We can observe that the collection of electrons is hindered and the total electron density inside the perovskite layer is significantly higher. A similar trend is found for the concentration of holes in the same **Figure 9A** where the hole density close to the ETL is significantly higher only in forward scan. The relatively high hole concentration close to ETL shields the electrons from flowing to the ETL. Both effects result in high recombination rates inside the bulk as shown in **Figure 9B**. Therefore, the forward scan displays a reduced output current compared to the reverse scan as we see in **Figure 3**.

Furthermore, looking back at **Figure 4**, the main reason for a higher HI at higher defect densities can be ascribed to the aforementioned charge accumulation and recombination (Sze and Ng, 2006). In fact, Shockley-Read-Hall recombination increases at higher defect densities that, together with the higher accumulation, results in a larger difference between the scan directions and thus stronger hysteresis in the J - V curve.

Energy States Contributing to Hysteresis

Our simulations reveal that recombination processes have a significant impact on hysteresis in PSCs. Such recombination

processes are associated with the concentration and energy of energy states and their capture-emission properties (Sze and Ng, 2006). As we observe in **Figure 5**, only energy states in a certain energy range contribute to hysteresis. This can be explained by looking at their average occupation as shown in **Figure 10** for electron and hole distributions as calculated in our simulated PSCs. The distributions depend on $E_{F,p}$ and $E_{F,n}$. The electron distribution function determines the occupation of an electronic state. Note that the value of the electron distribution function equivalent to 1 as average occupation indicates that energy states are fully occupied by electrons.

Defect states in regions 1 and 3 of **Figure 10A** cause hardly any hysteresis, because the number of trapped electrons in these states remains the same during the scan. They are either almost all occupied (region 1) or unoccupied (region 3). In region 2, however, there is a net emission of electrons to the valence band, but net capture of electrons from the conduction band. Which of two processes is dominant depends on the exact positions of the quasi Fermi-levels. Since the quasi Fermi-levels shift by a few tenths of an eV during a scan (see **Figure 7**), the amount of charge that is trapped close to the interface will strongly change during a scan. This build-up of charge is also clearly visible in **Figure 8**.

Figure 11 shows simulated J - V scans for the device architectures and defect distributions as summarized in **Table 5**. **Figures 11A–C** correspond to n-i-p architecture and **Figure 11D** represents a p-i-n structure. The simulated device in **Figure 11A** exhibits only acceptor like defects near the ETL with an average energy $E_{t,0} = 0.25$ eV. The device in **Figure 11B** exhibits only donor type defects near the HTL with an average energy $E_{t,0} = 1.3$ eV. Hysteresis is more apparent in **Figure 11B**

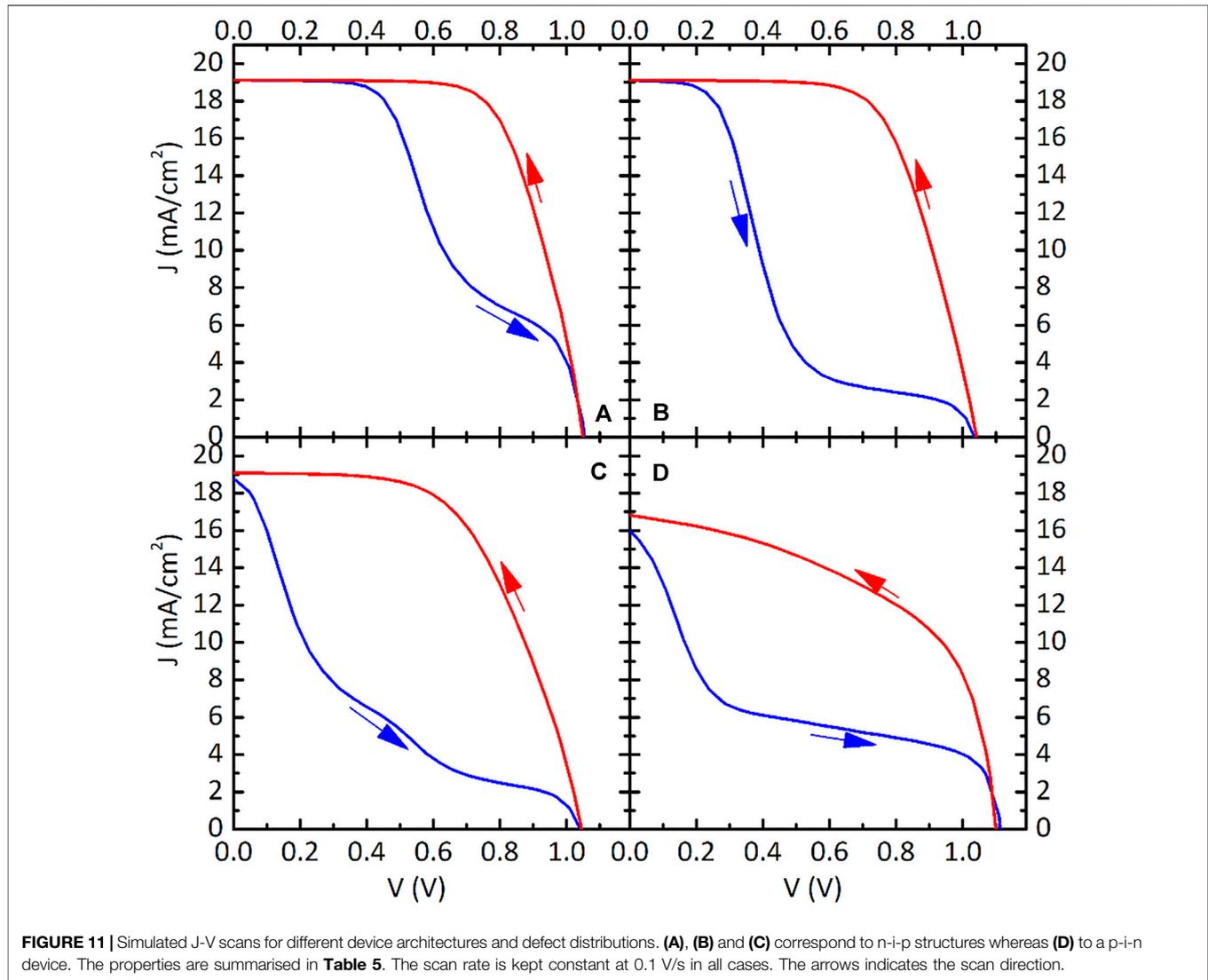


FIGURE 11 | Simulated J-V scans for different device architectures and defect distributions. (A), (B) and (C) correspond to n-i-p structures whereas (D) to a p-i-n device. The properties are summarised in Table 5. The scan rate is kept constant at 0.1 V/s in all cases. The arrows indicates the scan direction.

TABLE 5 | Properties used for simulations of J-V curves in Figure 11.

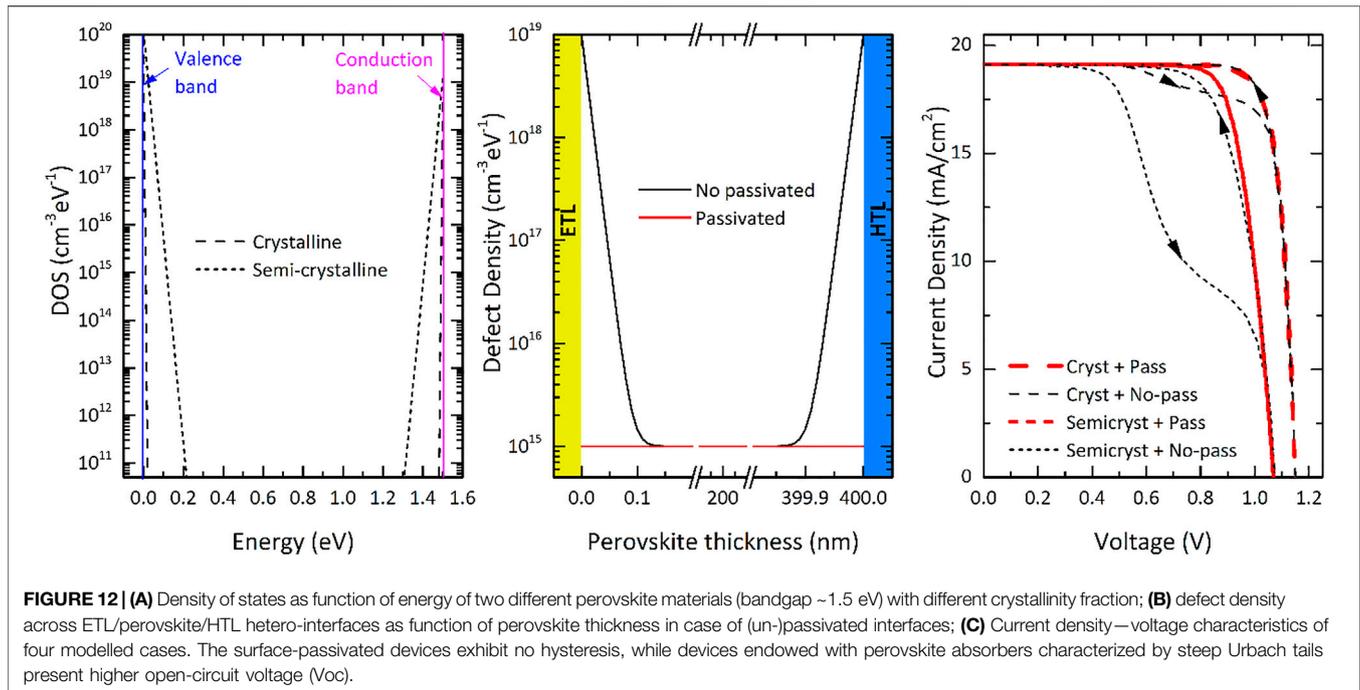
Figure	Architecture	Defect type	$E_{t,0}$ (eV)	$N_{t,ETL}$ (cm ⁻³)	$N_{t,HTL}$ (cm ⁻³)	σ (cm ²)
a	n-i-p	Acceptor	0.25	10^{19}	0	10^{-24}
b	n-i-p	Donor	1.3	0	10^{19}	10^{-24}
c	n-i-p	Acceptor	0.25	10^{19}	0	10^{-24}
		Donor	1.3	0	10^{19}	10^{-24}
d	p-i-n	Acceptor	0.25	3×10^{18}	0	10^{-24}

than in Figure 11A, showing a stronger “S-shaped” kink. Figure 11C reports the J-V scan of a device with defects near the ETL and defects near the HTL. This shows that hysteresis is even stronger if defects of both scenarios are present in the same device. In a way, the detrimental effect of charge polarisation on both sides of the perovskite layer adds up. Our model can be easily extended to other device architectures. For instance, Figure 12D shows the J-V curves we simulated for a p-i-n structure from Ref.

(Neukom, 2019). Hysteresis is clearly present in the J-V curves and the forward scan has again a strong “S-shaped” kink.

DISCUSSION

Looking at Figure 5, there are two energy ranges (around $E_{t,0} = 1.26$ eV and $E_{t,0} = 0.27$ eV) in which electronic energy states



would give rise to high HI's. Both density-functional theory (DFT) calculations and measurements from literature indicate that real devices have indeed electronic energy states in these ranges. Duan et al. (2015) have identified the defect energy distribution which reveals a deep defect state at about 0.16 eV above the valence band in the MAPbI_3 perovskite using admittance spectroscopy. Similarly, Xue et al. found hole traps using admittance spectroscopy in the energy range 0.16–0.23 eV with a relatively large concentration $N_t = 10^{15}$ – 10^{16} cm^{-3} and a hole carrier capture cross-section in the range of 10^{-15} – 10^{-16} cm^2s^{-1} (Xue et al., 2020). These defects were identified as interface-type defects. Measurements done by Heo et al. (2015) revealed defects with a higher activation energy of 0.27–0.28 eV and defect density of 10^{17} cm^{-3} , slightly deeper than the aforementioned results. Shao et al. found even higher activation energies in the range of 0.35–0.40 eV. By means of photoluminescence measurements, the authors clearly verified that the majority of defect states are close to the surface of the MAPbI_3 films and that they are most likely electron defects. Moreover, they were only able to passivate these defects by the diffusion of PCBM into the perovskite using thermal annealing. This experimental observation is in good agreement with our model representing defects that are not strictly localized at the interface, but that instead gradually fade away from the interface into the perovskite absorber.

The origin of those defect states is possibly attributed to the presence of interstitial iodine. According to DFT calculations, an acceptor-like defect with $E_T = 0.18$ eV above the valence band edge is introduced by such defects (Du, 2014). The interstitial iodine is the only one among the native defects (i.e., vacancies, interstitials, and antisites) causing a low-energy defect state (Ball and Petrozza, 2016). Moreover, Mosconi et al. (2016) found

defects related to iodine with characteristic energy of 0.15 eV above the valence band. DFT analysis of surface defects showed that only iodine interstitial has a deep carrier-trapping state (Urutani and Yamashita, 2017). Hence, the hysteresis might be related to the slow movement and recombination of carriers through energy states linked to ionized molecules.

These insights are crucial for the development of high-efficiency and hysteresis-free PSCs. In our simulation platform we are able to evaluate the crystallinity of the perovskite in terms of characteristic energy of the band tail states (Urbach energy). Accordingly, higher values of characteristic energy correspond to amorphous structures while minimal values to crystalline structures (Wager, 2017). Similarly, the quality of the passivation is considered in terms of $N_{T,ETL}$ and $N_{T,HTL}$. We observe in **Figure 12** that high quality (= high crystallinity) perovskite material increases the device open-circuit voltage. However we find that solely improving the perovskite material or the surface passivation is not sufficient to eliminate the hysteresis. Only the concurrent implementation of both high quality perovskite material and surface passivation can yield highest efficiency with negligible hysteresis.

It should be noted that our results do not reproduce different open-circuit voltage (V_{oc}) values as some experimental J-V curves do. This was also noted by van Reenen et al. when they modeled hysteresis using ion migration (van Reenen et al., 2015). Further research is needed in order to explain the mechanisms leading to V_{oc} mismatch during hysteresis in perovskite solar cells.

It is often suggested that ion migration is a primary cause of hysteresis. The hypothesis is that slowly excess ions are present in the perovskite crystal, that slowly move through the perovskite bulk and accumulate at the interfaces under short circuit conditions (Snaith et al., 2014). In fact, perovskites exhibit high ionic conductivity

caused by the migration of halide-ions (Mizusaki et al., 1983) but observed ion migration lengths are only 1/3 of a common perovskite layer thickness (110–130 nm) (Lee et al., 2017). Additionally, hysteresis has been successfully emulated using mobile ions (van Reenen et al., 2015; Walter et al., 2018), but it strongly depends on the surface recombination at perovskite/HTL and/ETL interfaces (Neukom et al., 2017; Neukom, 2019). This suggests that hysteresis can be reduced by changing the interfacial contact materials and thus reducing recombination mechanisms at the interfaces (Calado et al., 2016). Nevertheless, to elucidate the role of ion migration, it is important to obtain a better understanding of possible mechanisms like chemical binding or complexation at the interfaces (Weber et al., 2018). The simulations described in this work reveal that hysteresis in perovskite solar cells can be mimicked by explicitly modelling shadow interface defects. Our simulation results are consistent with the fact that surface passivation can be used to eliminate hysteresis (Shao et al., 2014; Wojciechowski et al., 2014; Jiang et al., 2019). Moreover, several works reported experimental and theoretical evidence for shallow defect states in perovskites (Yin et al., 2014a; Yin et al., 2014b; Baumann et al., 2015; Shi et al., 2015; Wright et al., 2017; Ni et al., 2020). In this respect, further empirical research is needed to characterize the capture-emission times of shallow defects. All aspects considered, additional modeling studies could help to improve our understanding about the combined effect of ion migration and slow recombination processes, as well as the implications of limited ion migration lengths.

CONCLUSION

In this work we have explained the hysteretic behaviour of PSCs in terms of charge carrier accumulation due to energy states near the interfaces with the perovskite absorber. Such phenomena were modelled using fundamental semiconductor physics equations numerically solved in the finite element simulator TCAD Sentaurus.

Our simulations revealed that hysteretic behaviour can be caused by defects near the interface with ETL (or HTL) with the following characteristics: 1) density $N_t > 10^{18} \text{ cm}^{-3}$ 2) capture cross-section $\sigma \approx 10^{-23} \text{ cm}^2$, and 3) defect energy $E_t \approx 0.25 \text{ eV}$ with respect to VBE (or $E_t \approx 0.2 \text{ eV}$ with respect to CBE). Such

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values are consistent with experimental findings reported in literature.

Furthermore, stronger hysteresis at higher defect densities near the ETL or HTL revealed that the hysteretic behaviour is due to recombination processes. We provided an explanation of the observed phenomena in terms of slow capture and emission by interface defect states with capture cross-sections lower than 10^{-22} cm^2 . Moreover, the effect is most apparent when the energy states have energies close to the quasi-Fermi levels.

Finally, J - V simulations at different scan rates demonstrated realistic behaviour in the analysis of hysteresis for different scan rates. In fact, we found that there is a scan rate which maximizes hysteresis as observed in experimental studies.

In conclusion, our results show that hysteresis can be explained using fundamental semiconductor physics alone with realistic defect distributions in both the spatial and energetic domains. This supports the claim that interface defects play a crucial role in the formation of hysteresis. At the same time, we observe that independently improving perovskite material or quenching interface defects is not sufficient to eliminate the hysteresis. Rather, only concurrently pursuing high quality perovskite material and surface passivation yields highest efficiency with negligible hysteresis. Our model can be easily extended and adapted to different device architectures and defect distributions for a custom optimization that addresses different fabrication sequence, absorber material formulations and choice of supporting layers.

DATA AVAILABILITY STATEMENT

The raw data supporting the conclusion of this article will be made available by the authors, without undue reservation.

AUTHOR CONTRIBUTIONS

RH and PP conceived the idea. RH designed the simulation template. LM, RS, and OI contributed to the definition and presentation of the paper content. RH, PP, LM, RS, and OI discussed the results. RH, PP, and OI organized the research. RH wrote the paper, and all other authors provided feedback.

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